Docket No.: IMECV.000GEN Customer No. 20995

## STATEMENT UNDER 37 CFR § 3.73(b) ESTABLISHMENT OF ASSIGNEE

**Applicant** 

: Bartlomiej Pawlak

App. No.

: 10/598755

Filed

: 9/11/2006

For

: FIELD EFFECT TRANSISTOR AND METHOD OF

MANUFACTURING A FIELD EFFECT TRANSISTOR

Examiner

: Shaun M. Campbell

Group Art Unit

2829

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## Dear Sir:

This document is being filed with a copy of a Power of Attorney signed by the Assignee. This Statement sets forth the chain of title of the above-identified application.

IMEC, is the Assignee of the entire right, title, and interest of the above-referenced application by virtue of:

A chain of title, in reverse order, from the inventor(s) to the current Assignee as shown by the following recorded assignments:

- The attached copy of the Assignment being forwarded to the Recordation Branch concurrently under separate cover.
- Assignment from Koninklijke Philips Electronics N.V. to NXP B.V. recorded in the United States Patent and Trademark Office on August 17, 2007, at Reel 019719, and Frame 0843.
- Assignment from Bartlomiej Jan Pawlak to Koninklijke Philips Electronics N.V. recorded in the United States Patent and Trademark Office on September 11, 2006, at Reel 018226, and Frame 0831.

Appl. No. :

10/598755

Filed

9/11/2006

Docket No. IMECV.000GEN Customer No. 20995

The undersigned is an agent of Customer Number 20995 and is authorized to act on behalf of the Assignee. Please recognize or change the correspondence address for the above-identified application to **Customer No. 20995.** 

Respectfully submitted,

KNOBBE, MAKTENS, OLSON & BEAR, LLP

Dated:

2/2/12

By:\_\_

John M. Carson Registration No. 34,303 Attorney of Record Customer No. 20995 (858) 707-4000

12692178 020112

## **ASSIGNMENT**

WHEREAS, NXP B.V., a Dutch corporation having offices at High Tech Campus 60, 5656 AG Eindhoven, Netherlands (hereinafter "ASSIGNOR"), represents and warrants that it is the sole owner of the entire right, title, and interest to certain new and useful improvements for which ASSIGNOR has filled United States issued Letters Patents and applications for Letters Patents in the United States (hereinafter "the Patents and Patent Applications") Identified in the attached Exhibit A.

WHEREAS, IMEC, a Belgian corporation having offices at Kapeldreef 75, 3001 Leuven, Belgium (hereinafter "ASSIGNEE") desires to purchase the entire right, title, and Interest in and to the inventions disclosed in the Patents and Patent Applications;

NOW, THEREFORE, for good and valuable consideration, the receipt of which is hereby acknowledged, ASSIGNOR hereby further acknowledges that it has sold, assigned, and transferred, and by these presents does hereby sell, assign, and transfer, unto ASSIGNEE, its successors, legal representatives, and assigns, the entire right, title, and interest throughout the world in, to, and under the said Improvements, and the said Patents and Patent Applications and all Patents that may be granted thereon, and all provisional applications relating thereto, and all divisions, continuations, reissues, reexaminations, renewals, and extensions thereof, and all rights of priority under international Conventions and applications for Letters Patent that may hereafter be filed for said improvements or for the said Patents and Patent Applications in any country or countries foreign to the United States; and ASSIGNOR hereby authorizes and requests the Commissioner of Patents of the United States, and any Official of any country foreign to the United States, whose duty it is to issue patents on applications as aforesaid, to issue all Letters Patents for said improvements and all Letters Patents resulting from the Patents and Patent Applications to ASSIGNEE, its successors, legal representatives, and assigns, in accordance with the terms of this Agreement.

ASSIGNOR does hereby sell, assign, transfer, and convey to ASSIGNEE, its successors, legal representatives, and assigns all claims for damages and all remedies arising out of any violation of the rights assigned hereby that may have accrued prior to the date of assignment to ASSIGNEE, or may accrue hereafter, including, but not limited to, the right to sue for, collect, and retain damages for past infringements of the Letters Patents before or after issuance;

ASSIGNOR hereby covenants and agrees that it will communicate to ASSIGNEE, its successors, legal representatives, and assigns any facts known to ASSIGNOR respecting the Patents and Patent Applications immediately upon becoming aware of those facts, and that it will testify in any legal proceeding involving any of the Patents and Patent Applications, will sign all lawful papers, execute all divisional, continuing, and reissue applications, make all rightful oaths, and will generally do everything possible to ald ASSIGNEE, its successors, legal representatives, and assigns to obtain and enforce the Patents and Patent Applications in all countries.

COPY -DO NOT RECORD-

| IN TESTIMONY WHEREOF, I hereunto | set my hand and seal this $25^{60}$ day of |
|----------------------------------|--|
| 20 (2                            |  |
|                                  | NXP BLY                                    |
|                                  | By: Manc M. Schurten                       |
|                                  | Name Printed: Marc M. Schunten             |
|                                  | Title: Head IP Creation & Strategy         |
|                                  | Date:                                      |
|                                  |  |
|                                  |  |
| •                                |  |
| <u>Witner</u>                    | ssed by: Maderala                          |
|                                  | Name: Shanna Maraby - Defecte              |

COPY -DO NOT RECORD-

## Exhibit A

| NXP Patent<br>Family | IMEC reference | Title  | Filing Date | Application No. |
|----------------------|----------------|--|-------------|-----------------|
| 001288               | 2007/034       | SEMICONDUCTOR DEVICE HAVING A POLYSILICON ELECTRODE INCLUDING AMORPHIZING, RECRYSTALLISING, AND REMOVING PART OF THE POLYSILICON ELECTRODE | 11/14/2008  | 11/917103       |
| GB040113             | 2009/223       | PLANAR DUAL GATE SEMICONDUCTOR DEVICE  | 11/22/2006  | 11/597816       |
| GB040126             | 2007/141       | SEMICONDUCTOR ON INSULATOR SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURE  | 7/9/2010    | 11/629419       |
| NL030079             | 2003/045       | METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE AND SEMICONDUCTOR DEVICE OBTAINED BY MEANS OF SUCH A METHOD                                 | 8/3/2005    | 10/544412       |
| NL030081             | 2003/047       | METHOD OF MANUFACTURING MOS<br>TRANSISTORS WITH GATE<br>ELECTRODES FORMED IN A PACKET OF<br>METAL LAYERS DEPOSITED UPON ONE<br>ANOTHER     | 8/3/2005    | 10/544413       |
| NL030347             | 2003/048       | GATE ELECTRODE FOR SEMICONDUCTOR DEVICES   | 9/22/2005   | 10/550741       |
| NL030623             | 2003/020       | FORMATION OF JUNCTIONS AND SILICIDES WITH REDUCED THERMAL BUDGET   | 11/30/2005  | 10/559069       |
| NL031072             | 2003/069       | METHOD OF FABRICATING A DOUBLE<br>GATE FIELD EFFECT TRANSISTOR<br>DEVICE, AND SUCH A DOUBLE GATE<br>FIELD EFFECT TRANSISTOR DEVICE         | 3/1/2006    | 10/570478       |
| NL031259             | 2003/079       | SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING SUCH A SEMICONDUCTOR DEVICE   | 4/11/2006   | 10/575288       |
| NL031497             | 2007/134       | METHOD FOR FORMING A STRAINED SI-CHANNEL IN A MOSFET STRUCTURE   | 6/13/2006   | 10/596422       |
| NL031498             | 2004/089       | SEMICONDUCTOR SUBSTRATE WITH<br>SOLID PHASE EPITAXIAL REGROWTH<br>WITH REDUCED JUNCTION LEAKAGE<br>AND METHOD OF PRODUCING SAME            | 6/19/2006   | 10/596612       |
| NL031500             | 2004/080       | SEMICONDUCTOR SUBSTRATE WITH<br>SOLID PHASE EPITAXIAL REGROWTH<br>WITH REDUCED DEPTH OF DOPING<br>PROFILE AND METHOD OF<br>PRODUCING SAME  | 4/24/2009   | 10/596603       |



| NXP Patent<br>Family | IMEC reference | Title   | Filing Date | Application No. |
|----------------------|----------------|---|-------------|-----------------|
| NL040276             | 2004/076       | FIELD EFFECT TRANSISTOR AND<br>METHOD OF MANUFACTURING A<br>FIELD EFFECT TRANSISTOR                 | 9/11/2006   | 10/598755       |
| NL040280             | 2004/078       | METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE INCLUDING DOPANT INTRODUCTION                        | 9/11/2006   | 10/598744       |
| NL040928             | 2007/137       | METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE AND SUCH A SEMICONDUCTOR DEVICE                      | 3/6/2009    | 11/574338       |
| NL040929             | 2007/138       | SEMICONDUCTOR DEVICE AND METHOD OF MANUFACTURING THEREOF  | 10/8/2007   | 11/574341       |
| NL041040             | 2007/135       | SEMICONDUCT DEVICE AND METHOD OF MANUFACTURING SUCH A SEMICONDUCTOR DEVICE                          | 11/12/2007  | 11/574245       |
| BE020043             | 2003/039       | METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE AND SEMICONDUCTOR DEVICE OBATINED WITH SUCH A METHOD | 6/16/2005   | 10/539224       |